



BSI Standards Publication

Device embedding assembly technology

Part 1: Generic specification for device embedded substrates

National foreword

This British Standard is the UK implementation of EN IEC 62878-1:2019. It is identical to IEC 62878-1:2019.

The UK participation in its preparation was entrusted to Technical Committee EPL/501, Electronic Assembly Technology.

A list of organizations represented on this committee can be obtained on request to its secretary.

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© The British Standards Institution 2019
Published by BSI Standards Limited 2019

ISBN 978 0 580 97304 8

ICS 31.180; 31.190

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This British Standard was published under the authority of the Standards Policy and Strategy Committee on 31 December 2019.

Amendments/corrigenda issued since publication

Date	Text affected
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English Version

Device embedding assembly technology - Part 1: Generic
specification for device embedded substrates
(IEC 62878-1:2019)

Techniques d'assemblage avec appareil(s) intégré(s) -
Partie 1: Spécification générique pour substrats avec
appareil(s) intégré(s)
(IEC 62878-1:2019)

Montageverfahren für eingebettete Bauteile - Teil 1:
Fachgrundspezifikation für Trägermaterial mit eingebetteten
Bauteilen
(IEC 62878-1:2019)

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European Committee for Electrotechnical Standardization
Comité Européen de Normalisation Electrotechnique
Europäisches Komitee für Elektrotechnische Normung

CEN-CENELEC Management Centre: Rue de la Science 23, B-1040 Brussels

European foreword

The text of document 91/1597/FDIS, future edition 1 of IEC 62878-1, prepared by IEC/TC 91 "Electronics assembly technology" was submitted to the IEC-CENELEC parallel vote and approved by CENELEC as EN IEC 62878-1:2019.

The following dates are fixed:

- latest date by which the document has to be implemented at national level by publication of an identical national standard or by endorsement (dop) 2020-08-18
- latest date by which the national standards conflicting with the document have to be withdrawn (dow) 2022-11-18

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Endorsement notice

The text of the International Standard IEC 62878-1:2019 was approved by CENELEC as a European Standard without any modification.

In the official version, for Bibliography, the following notes have to be added for the standards indicated:

IEC 60068-1:2013	NOTE	Harmonized as EN 60068-1:2014 (not modified)
IEC 60068-2-45	NOTE	Harmonized as EN 60068-2-45
IEC 60068-2-58	NOTE	Harmonized as EN 60068-2-58
IEC/TR 61340-5-2	NOTE	Harmonized as CLC/TR 61340-5-2
IEC 62421	NOTE	Harmonized as EN 62421

Annex ZA

(normative)

Normative references to international publications with their corresponding European publications

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

NOTE 1 Where an International Publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

NOTE 2 Up-to-date information on the latest versions of the European Standards listed in this annex is available here: www.cenelec.eu.

<u>Publication</u>	<u>Year</u>	<u>Title</u>	<u>EN/HD</u>	<u>Year</u>
IEC 60068-2-1	-	Environmental testing - Part 2-1: Tests - Test A: Cold	EN 60068-2-1	-
IEC 60068-2-2	-	Environmental testing - Part 2-2: Tests - Test B: Dry heat	EN 60068-2-2	-
IEC 60068-2-6	-	Environmental testing - Part 2-6: Tests - Test Fc: Vibration (sinusoidal)	EN 60068-2-6	-
IEC 60068-2-14	-	Environmental testing - Part 2-14: Tests - Test N: Change of temperature	EN 60068-2-14	-
IEC 60068-2-21	-	Environmental testing - Part 2-21: Tests - Test U: Robustness of terminations and integral mounting devices	EN 60068-2-21	-
IEC 60068-2-27	-	Environmental testing - Part 2-27: Tests - Test Ea and guidance: Shock	EN 60068-2-27	-
IEC 60068-2-69	-	Environmental testing – Part 2-69: Tests – Test Te/Tc: Solderability testing of electronic components and printed boards by the wetting balance (force measurement) method	EN 60068-2-69	-
IEC 60068-2-78	-	Environmental testing - Part 2-78: Tests - Test Cab: Damp heat, steady state	EN 60068-2-78	-
IEC 60194-2	-	Printed boards design, manufacture and assembly - Vocabulary - Part 2: Common usage in electronic technologies as well as printed board and electronic assembly technologies	-	-
IEC 61340-5-1	-	Electrostatics - Part 5-1: Protection of electronic devices from electrostatic phenomena - General requirements	EN 61340-5-1	-

EN IEC 62878-1:2019 (E)

<u>Publication</u>	<u>Year</u>	<u>Title</u>	<u>EN/HD</u>	<u>Year</u>
IEC 61340-5-3	-	Electrostatics - Part 5-3: Protection of electronic devices from electrostatic phenomena - Properties and requirements classification for packaging intended for electrostatic discharge sensitive devices	EN 61340-5-3	-
IEC 61760-4	-	Surface mounting technology - Part 4: Classification, packaging, labelling and handling of moisture sensitive devices	EN 61760-4	-
IEC 62137-1-4	-	Surface mounting technology - Environmental and endurance test methods for surface mount solder joint - Part 1-4: Cyclic bending test	EN 62137-1-4	-
IEC 62878-1-1	-	Device embedded substrate - Part 1-1: Generic specification - Test methods	EN 62878-1-1	-
IEC/TR 62878-2-2	-	Device embedded substrate - Part 2-2: Guidelines - Electrical testing	-	-
IEC/TS 62878-2-1	-	Device embedded substrate - Part 2-1: Guidelines - General description of technology	-	-
IEC/TS 62878-2-3	-	Device embedded substrate - Part 2-3: Guidelines - Design guide	-	-
IEC/TS 62878-2-4	-	Device embedded substrate - Part 2-4: Guidelines - Test element groups (TEG)	-	-
J-STD 033	-	Handling, Packing, Shipping, and Use of Moisture/Reflow and/or Process Sensitive Components	-	-

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